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# Positive linear magnetoresistance effect in disordered $L2_1B$ -type $Mn_2CoAl$ epitaxial films

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## Abstract

The inverse Heusler alloy  $\text{Mn}_2\text{CoAl}$  is known as a spin gapless semiconductor (SGS). It is believed that the positive linear magnetoresistance (PLMR) effect observed at low temperatures means the quantum linear MR effect in the gapless electronic band structures near the Fermi level, i.e., evidence for the realization of SGS [S. Ouardi *et al.*, Phys. Rev. Lett. **110**, 100401 (2013)]. For this reason, one presumes that the observation of the PLMR effect is indirect proof of the demonstration of  $XA$ -type  $\text{Mn}_2\text{CoAl}$  consisting of the inverse Heusler structure. In this article, we observe the PLMR effect at 10 K in homogeneous and single-phase  $\text{Mn}_2\text{CoAl}$  epitaxial films grown by low-temperature molecular beam epitaxy at  $100^\circ\text{C}$ . From anomalous X-ray diffraction measurements and analyses, we clarify that the  $100^\circ\text{C}$ -grown  $\text{Mn}_2\text{CoAl}$  epitaxial film is not composed of the  $XA$ -type structure but a disordered  $L2_1B$ -type structure including some amount of  $\text{Mn}(\text{A-site}) \Leftrightarrow \text{Co}(\text{C-site})$  swapping and  $\text{Mn}(\text{B-site}) \Leftrightarrow \text{Al}(\text{D-site})$  swapping. On the basis of first-principles density-functional theory calculations, we discuss the correlation between the PLMR effect observed at 10 K and the possible electronic band structure in the disordered  $L2_1B$ -type  $\text{Mn}_2\text{CoAl}$ .

## I. INTRODUCTION

The spin gapless semiconductor (SGS) is a new class of semiconductors with the zero-gap electronic band structure near the Fermi level in one spin channel, and the usual finite band gap structure in another spin channel [1, 2]. In the research field of spintronics [3], the special electronic band structure is expected to offer unique properties both high mobility zero-gap semiconductors and half-metallic materials. If the SGSs are realized, one can utilize these as highly efficient spin injectors and highly spin-polarized channels with tunable magnetic properties by applying an electric field [1, 2]. Very recently, some of novel applications such as reconfigurable magnetic tunnel diode and transistor structures were also proposed [4, 5].

To date, candidate materials such as Co or Mn-doped PdPbO<sub>2</sub> [1, 6], graphene nanoribbons [2, 7], silicene nanoribbons [8], MoSn [9], and some of Heusler alloys [10–17] have been predicted as SGSs. As unique physical properties in SGSs, (i) weak temperature-dependent conductivity (resistivity), (ii) high spin polarization, (iii) vanishing the Seebeck coefficient, and (iv) positive linear magnetoresistance (PLMR) effect derived from the quantum linear MR effect [18] have been reported for Co-doped PdPbO<sub>2</sub> [19] and several Heusler alloys [10, 20–26].

As a spintronic material, one of the ternary Heusler alloys, Mn<sub>2</sub>CoAl, is a popular SGS because the above SGS-like physical properties have been firstly reported in a bulk sample in 2013 [10]. Notably, it is believed that the Hg<sub>2</sub>TiCu-type inverse Heusler (*XA*-type) structure is essential to realize the electronic band structure showing SGS-like physical properties [27]. In the first report for the bulk Mn<sub>2</sub>CoAl [10], a magnetic moment of  $\sim 2.0 \mu_B/\text{f.u.}$  consistent with the theoretical prediction was demonstrated. In addition, the weak negative (positive) temperature dependence of electrical resistivity  $\rho$  (conductivity), a very small anomalous Hall conductivity ( $\sigma_{\text{AHC}}$ ) of 21.8 S/cm, and the PLMR effect arising from the quantum linear MR effect at low temperatures were observed. Up to now, many groups have tried to achieve Mn<sub>2</sub>CoAl films for spintronic devices, and the weak negative temperature-dependent  $\rho$  and small  $\sigma_{\text{AHC}}$  values have also been observed [28–34]. However, the PLMR effect at low temperatures for the Mn<sub>2</sub>CoAl films has never been observed.

Very recently, Xu *et al.* investigated atomic-level ordered structure, electrical, and magnetic properties for bulk Mn<sub>2</sub>CoAl samples in detail [35], where high-angle annular dark-field scanning transmission electron microscopy (HAADF-STEM) and anomalous X-ray diffrac-

tion (AXRD) measurements were used to distinguish the structural difference between the  $XA$ -type structure and conventional  $L2_1$ -type structure. Even for the bulk  $\text{Mn}_2\text{CoAl}$  samples including inhomogeneous and disordered structures, they observed the weak negative temperature-dependent  $\rho$  and small  $\sigma_{\text{AHC}}$  values. From the detailed comparisons, one can understand that there is no correlation among the weak negative temperature-dependent  $\rho$ , small  $\sigma_{\text{AHC}}$  values, and the formation of the  $XA$ -type structure that is essential to the SGS electronic band structure [27].

In this article, we experimentally observe the PLMR effect at 10 K in homogeneous and single-phase  $\text{Mn}_2\text{CoAl}$  epitaxial films grown by low-temperature molecular beam epitaxy (MBE) at  $100^\circ\text{C}$ . In addition to the simple structural, electrical, and magnetotransport characterizations, we perform the AXRD measurements and analyses for the  $100^\circ\text{C}$ -grown  $\text{Mn}_2\text{CoAl}$  epitaxial film. As a result, we find that the  $100^\circ\text{C}$ -grown  $\text{Mn}_2\text{CoAl}$  epitaxial film is not composed of an  $XA$ -type structure but a disordered  $L2_1B$ -type structure having some amount of  $\text{Mn}(\text{A-site}) \Leftrightarrow \text{Co}(\text{C-site})$  swapping and  $\text{Mn}(\text{B-site}) \Leftrightarrow \text{Al}(\text{D-site})$  swapping. On the basis of the structure determined here, we discuss the correlation between the PLMR effect and a possible electronic band structure calculated by the first-principles density-functional theory. We suggest that there is no correlation between the presence of the PLMR effect at low temperatures and the realization of the  $XA$ -type structure in  $\text{Mn}_2\text{CoAl}$ .

## II. FILM GROWTH AND MEASUREMENTS

Schematics of the crystal structures considered as  $\text{Mn}_2\text{CoAl}$  are shown in Fig. 1(a) [10, 27, 35–37]. As shown in the left, when Mn atoms occupy A(0, 0, 0) and B( $\frac{1}{4}$ ,  $\frac{1}{4}$ ,  $\frac{1}{4}$ ) sites and Co atoms and Al atoms occupy C( $\frac{1}{2}$ ,  $\frac{1}{2}$ ,  $\frac{1}{2}$ ) and D( $\frac{3}{4}$ ,  $\frac{3}{4}$ ,  $\frac{3}{4}$ ) sites, respectively, the crystal structure is so-called the  $XA$ -type structure, leading to SGS-like electronic band structures [10, 27]. The A, B, C and D sites correspond to the following Wyckoff positions, 4a, 4c, 4b and 4d, respectively. When Mn and Co atoms randomly occupy A and C sites and Mn atoms occupy B site, as shown in the right, it becomes an  $L2_1B$ -type structure, which is not an SGS [27, 36]. Notably, there is no report on the direct evidence for the formation of the  $XA$ -type structure for  $\text{Mn}_2\text{CoAl}$  up to now.

In this study,  $\text{Mn}_2\text{CoAl}$  films were grown on  $\text{MgAl}_2\text{O}_4(001)$  substrates (sample size:  $1 \times 1 \text{ cm}^2$ ) by nonstoichiometric molecular beam epitaxy (MBE) techniques [32, 38–42], where

the film thickness was tuned to be 3.5, 15, and 50 nm according to each measurement. Since the mismatch between the lattice constant of  $\text{Mn}_2\text{CoAl}$  and the half diagonal length of the lattice constant of  $\text{MgAl}_2\text{O}_4$  ( $0.808 \text{ nm} \times 1/\sqrt{2} = 0.571 \text{ nm}$ ) is  $\sim 1.5 \%$  [32], we can expect an epitaxial relationship of  $\text{Mn}_2\text{CoAl}[100](001)//\text{MgAl}_2\text{O}_4[110](001)$ . For the film growth, the  $\text{MgAl}_2\text{O}_4(001)$  substrates used here were chemically cleaned by Semico Clean 56 (Furuuchi Chemical) and then were loaded into an MBE chamber, followed by the heat treatment at  $600^\circ\text{C}$  for 1 hour under a base pressure of  $\sim 10^{-7}$  Pa. From *in-situ* reflection high-energy electron diffraction (RHEED) observations, good surface flatness on the used  $\text{MgAl}_2\text{O}_4(001)$  substrate was confirmed (not shown here). After that, we set a growth temperature of  $100^\circ\text{C}$  and grew  $\text{Mn}_2\text{CoAl}$  films by co-evaporating Mn, Co, and Al using Knudsen cells, where the supplied atomic composition ratio of Mn:Co:Al was 2.0:1.1:2.0 during the growth [32]. Structural characterizations were carried out by *in-situ* RHEED, XRD, AXRD, HAADF-STEM, and energy-dispersive X-ray spectroscopy (EDX).

To measure electrical and magnetotransport properties, the grown  $\text{Mn}_2\text{CoAl}$  films were patterned into Hall-bar devices with  $80\text{-}\mu\text{m}$  width and  $400\text{-}\mu\text{m}$  length, as shown in the inset of Fig. 3, by a conventional photolithography and Ar ion-milling techniques. Electrical and magnetotransport properties were measured using a four-terminal dc method in a physical property measurement system (Quantum Design) at various temperatures. External magnetic fields were perpendicular ( $B_z$ ) and parallel ( $B_y$ ) to the film plane for Hall-effect and MR measurements, respectively.

### III. RESULTS

#### A. Conventional structural characterizations

During the growth of  $100^\circ\text{C}$ -grown  $\text{Mn}_2\text{CoAl}$  films, we observe the *in-situ* RHEED image of the symmetrical streaks [inset of Fig. 1(b)], indicating good two-dimensional epitaxial growth of the  $\text{Mn}_2\text{CoAl}$  films. Figure 1(b) shows a conventional  $\theta$ - $2\theta$  XRD pattern for the  $100^\circ\text{C}$ -grown  $\text{Mn}_2\text{CoAl}$  film (red), together with that for a  $\text{MgAl}_2\text{O}_4(001)$  substrate (black) using  $\text{Cu K}\alpha$  radiation at  $0.15418 \text{ nm}$ . In addition to the diffraction peaks originating from  $\text{MgAl}_2\text{O}_4$  substrates, the 002 and 004 diffraction peaks from  $\text{Mn}_2\text{CoAl}$  are clearly observed at  $2\theta$  values of  $\sim 30^\circ$  and  $\sim 63^\circ$ , respectively, indicating the formation of [001]-oriented epitaxial

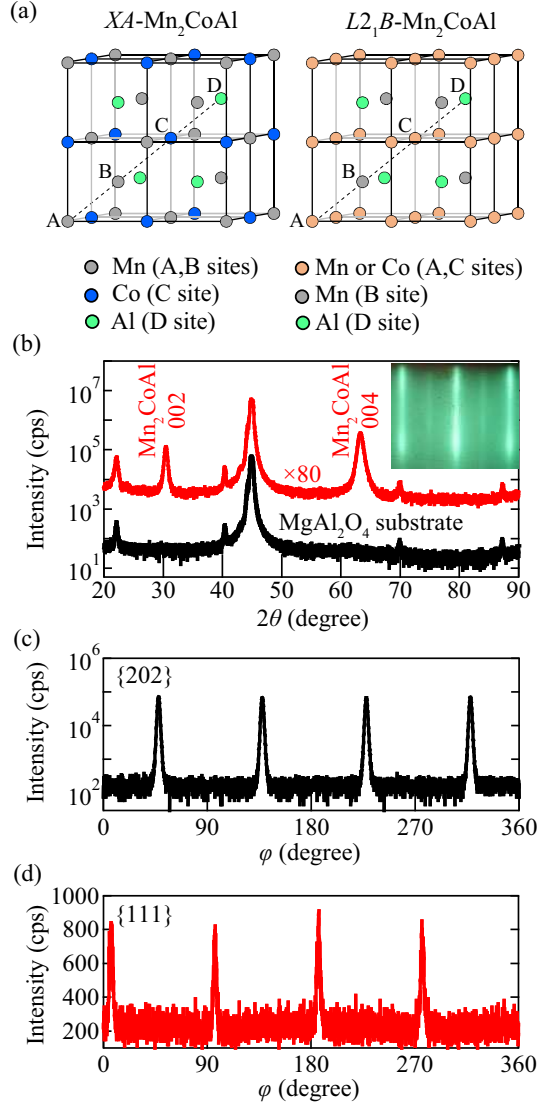


FIG. 1. (Color online) (a) Crystal structures of inverse Heusler  $XA$ -type (left) and  $L2_1B$ -type (right)  $Mn_2CoAl$ . The A, B, C and D sites correspond to 4a, 4c, 4b and 4d in Wyckoff positions, respectively. (b)  $\theta$ - $2\theta$  XRD pattern of the  $100^\circ\text{C}$ -grown  $Mn_2CoAl$  film grown on  $MgAl_2O_4(001)$  (red), together with that for a  $MgAl_2O_4(001)$  substrate (black). The inset shows a RHEED image of the  $Mn_2CoAl$  surface after the growth. (c) and (d) are XRD  $\phi$ -scan profiles in  $\{202\}$  and  $\{111\}$ , respectively, for the  $100^\circ\text{C}$ -grown  $Mn_2CoAl$  film.

$Mn_2CoAl$  films. The lattice constant is estimated to be  $\sim 0.588$  nm, comparable to a reported bulk sample ( $\sim 0.584$  nm) [35] and low-temperature ( $\leq 300^\circ\text{C}$ ) grown films ( $0.586\sim 0.587$  nm) [32, 33], while these values are slightly larger than the theoretical value of  $0.576\sim 0.577$  nm [32, 36]. From the XRD  $\phi$ -scan profile in  $\{202\}$  for the  $Mn_2CoAl$  film in Fig. 1(c), the in-

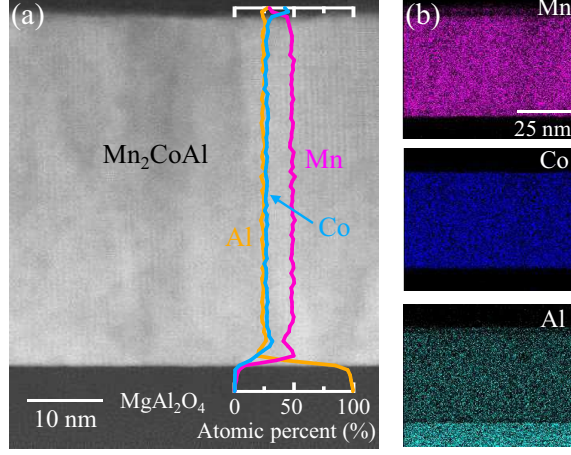


FIG. 2. (Color online) (a) HAADF-STEM image of the 100 °C-grown  $\text{Mn}_2\text{CoAl}$  film on  $\text{MgAl}_2\text{O}_4(001)$ , together with EDX line profiles of Mn, Co, Al. (b) EDX elemental maps of Mn, Co, Al for the same  $\text{Mn}_2\text{CoAl}/\text{MgAl}_2\text{O}_4(001)$  heterostructure.

plane crystal orientation of  $\text{Mn}_2\text{CoAl}[100](001)//\text{MgAl}_2\text{O}_4[110](001)$  is confirmed. Figure 1(d) shows an XRD  $\phi$ -scan profile in  $\{111\}$  for the 100°C-grown  $\text{Mn}_2\text{CoAl}$  film. Sharp diffraction peaks with fourfold symmetry are clearly seen, indicating the formation of an  $XA$ - or  $L2_1B$ -type structure in the 100°C-grown  $\text{Mn}_2\text{CoAl}$  films. From the comparisons of these intensities, we roughly estimate the degree of  $B2$  and  $L2_1$  ordering,  $S_{B2}$  and  $S_{L2_1}$ , for the  $\text{Mn}_2\text{CoAl}$  films from the following equations [43, 44],

$$S_{B2} = \sqrt{\frac{I_{002}/I_{004}}{I_{002}^R/I_{004}^R}}, \quad S_{L2_1} = \frac{2}{3 - S_{B2}} \sqrt{\frac{I_{111}/I_{202}}{I_{111}^R/I_{202}^R}}, \quad (1)$$

where  $I_{hkl}$  and  $I_{hkl}^R$  are the experimental and theoretical peak intensities for the  $hkl$  plane. As a result, the values of  $S_{B2}$  and  $S_{L2_1}$  are  $\sim 1$  and  $\sim 0.4$ , respectively. These results indicate that the 100°C-grown  $\text{Mn}_2\text{CoAl}$  films include some amount of Mn(B-site) and Al(D-site) disorder.

Figure 2 shows a typical HAADF-STEM image of the 100°C-grown  $\text{Mn}_2\text{CoAl}$  film, together with the results of the EDX line scan and elemental maps. In the HAADF-STEM image, the contrast within the  $\text{Mn}_2\text{CoAl}$  layer is uniform, indicating a compositionally homogeneous and single-phase film over the measured area. According to the EDX line profiles from the  $\text{Mn}_2\text{CoAl}/\text{MgAl}_2\text{O}_4(001)$  interface, the chemical composition in the  $\text{Mn}_2\text{CoAl}$  layer along the vertical direction is almost stoichiometric (Mn:Co:Al = 2:1:1) [Fig. 2(a)].



The EDX element maps in Fig. 2(b) indicate the absence of the phase separation in the 100°C-grown Mn<sub>2</sub>CoAl films. From these structural characterizations, homogeneous and single-phase Mn<sub>2</sub>CoAl epitaxial films are demonstrated even at an extremely low growth temperature of 100°C.

### B. Electrical resistivity and anomalous Hall conductivity

Figure 3(a) shows the temperature dependence of  $\rho$  for 3.5 nm-thick Mn<sub>2</sub>CoAl films, together with magnetization curves measured at 10 K and 300 K in the inset. Weak negative temperature-dependent  $\rho$ , similar to those observed for the bulk [10, 35] and thin-film samples [29–34], is observed. In addition, magnetic moments at 10 K and at 300 K are almost the same as those for bulk in Ref. [10] and for epitaxial films in Ref. [32].

The magnetic-field ( $B_z$ ) dependence of the Hall conductivity ( $\sigma_{yx}$ ) at various temperatures is displayed in Fig. 3(b). A small temperature dependence of  $\sigma_{yx}$ , similar to the temperature dependence of  $\rho$  in Fig. 3(a), is also observed. The value of  $\sigma_{\text{AHC}}$  can be estimated to be  $\sim 16$  S/cm, comparable to that for thin-film samples [28, 32], from the extrapolation of the  $\sigma_{yx}$ - $B_z$  curve above 7.0 T towards zero field. Such small values of  $\sigma_{\text{AHC}}$  were theoretically explained by the electronic band structure of Mn<sub>2</sub>CoAl [10, 32]. Although the homogeneous and single-phase Mn<sub>2</sub>CoAl epitaxial films with an  $XA$ - or  $L2_1B$ -type structure have been confirmed in the previous subsection (A), the above features in Fig. 3 are not evidence for the formation of  $XA$ -type Mn<sub>2</sub>CoAl [32, 35].

We also estimate the value of carrier concentration  $p$  by using the single-band model,  $p = 1/qR_H$ , where  $q$  is the elemental charge and  $R_H$  is the Hall coefficient estimated from the slope of Hall voltages at high magnetic fields ( $\geq 7.0$  T) after subtracting its anomalous Hall component. For the 100°C-grown homogeneous and single-phase Mn<sub>2</sub>CoAl epitaxial films, the normal Hall voltage is positive, indicating the charge carriers are holes. Also, the values of  $p$  are estimated to be  $\sim 1.9 \times 10^{22}$  cm<sup>-3</sup> at 300 K and  $\sim 2.0 \times 10^{22}$  cm<sup>-3</sup> at 10 K, two orders of magnitude higher than polycrystalline bulk Mn<sub>2</sub>CoAl [10]. We speculate that there are some disordered structures, resulting in the high carrier concentration, in the 100°C-grown Mn<sub>2</sub>CoAl films [27, 32]. These results were reproductively observed for 15 and 50 nm-thick Mn<sub>2</sub>CoAl epitaxial films.

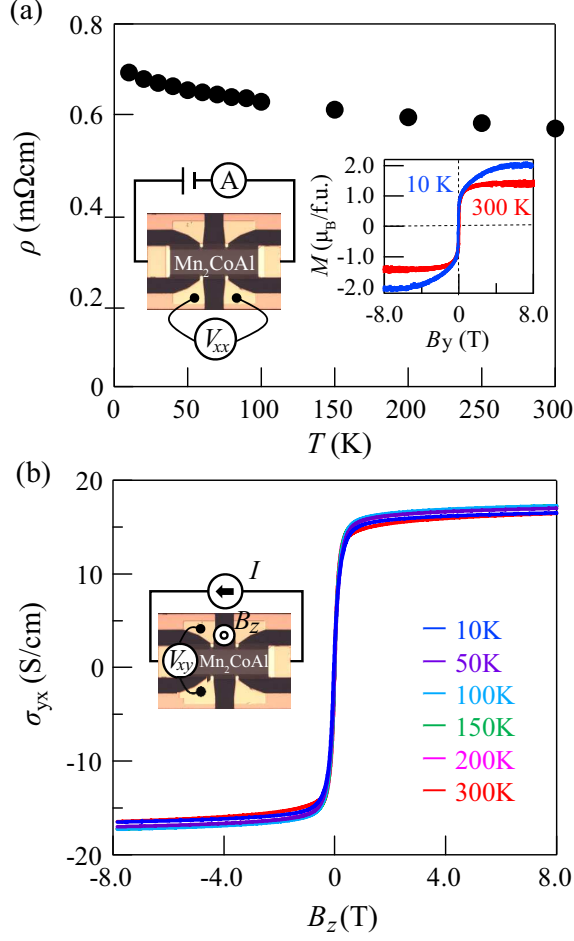


FIG. 3. (Color online) (a) Temperature dependence of the electrical resistivity  $\rho$  and (b) Hall conductivity  $\sigma_{yx}$  as a function of out-of-plane external magnetic fields at various temperatures for the 100°C-grown  $\text{Mn}_2\text{CoAl}$  film. The inset pictures show micrographs of the fabricated Hall-bar devices including the measurement scheme and  $M$ - $B_y$  curve at 10 K and 300 K for the 100°C-grown  $\text{Mn}_2\text{CoAl}$  film.

### C. Magnetoresistance

We focus on the magnetoresistance (MR) effect of the 100°C-grown  $\text{Mn}_2\text{CoAl}$  epitaxial films. In general, MR in ferromagnetic materials exhibit negative changes due to the suppression of the spin-dependent carrier scattering with increasing  $H$  [45, 46]. Above  $T_C$ , the positive changes in the MR, attributed to the carrier scattering derived from Lorentz force with increasing  $H$ , can be observed, where the Lorentz force is proportional to the square of  $H$  [47]. However, for bulk  $\text{Mn}_2\text{CoAl}$  [10], it was reported that the PLMR effect arising

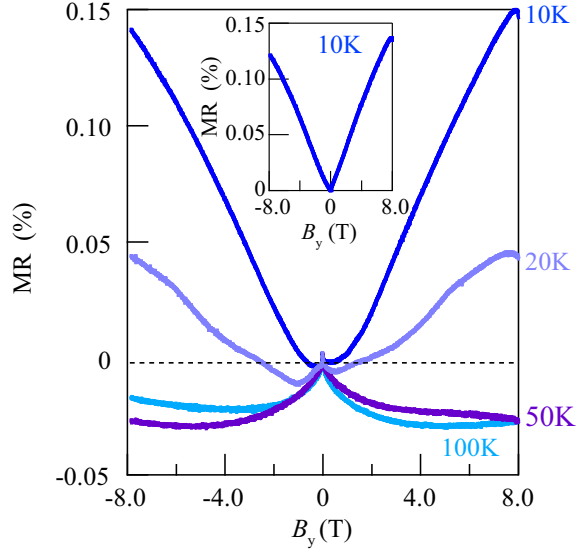


FIG. 4. (Color online) Magnetoresistance (MR) ratio as a function of in-plane external magnetic fields at various temperatures. The inset shows an MR curve for another device at 10 K.

from the quantum linear MR effect described elsewhere [18, 48] was observed. In fact, the quantum linear MR effect was observed for various zero-gap materials [49–52].

Figure 4 shows the field-dependent MR ratio for a 3.5 nm-thick  $\text{Mn}_2\text{CoAl}$  epitaxial film at various temperatures, where the MR ratio is defined as  $\{[R_{xx}(B_y) - R_{xx}(0)]/R_{xx}(0)\} \times 100\%$ , and  $R_{xx}(B_y)$  and  $R_{xx}(0)$  are the electrical resistance with and without applying in-plane external magnetic fields ( $B_y$ ), respectively. With varying the measurement temperature from 50 to 10 K, the MR features markedly change from negative to positive and the PLMR effect is clearly observed at 10 K, which is reproduced for another 100°C-grown  $\text{Mn}_2\text{CoAl}$  film as shown in the inset. Because the 100°C-grown  $\text{Mn}_2\text{CoAl}$  epitaxial film shows ferromagnetic nature at 10 K as shown in the inset of Fig. 3(a), we speculate that the observed PLMR effect arises from the quantum linear MR effect due to the special electronic structure near the Fermi level at this stage [18, 48].

However, the size of the MR ratio observed in Fig. 4 was much smaller than those observed in the previous work on the bulk  $\text{Mn}_2\text{CoAl}$  [10]. It has been discussed that the size of the MR ratio depends on the carrier mobility [51]. A similar feature has already been observed for low-temperature grown  $\text{CoFeVSi}$  epitaxial films [23]. From these results, although we can conclude that homogeneous and single-phase  $\text{Mn}_2\text{CoAl}$  epitaxial films evidently show the PLMR effect at 10 K, there is still no evidence for the formation of the  $XA$ -type structure.

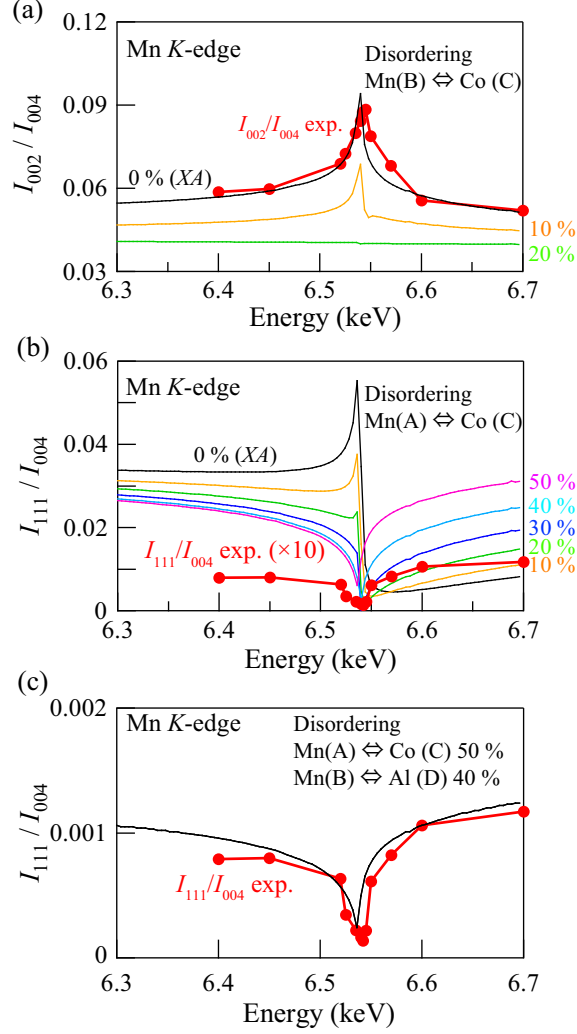


FIG. 5. (Color online) X-ray energy dependence of the calculated and experimental (a)  $I_{002}/I_{004}$  with the Mn(B-site) ↔ Co(C-site) disorder and (b)  $I_{111}/I_{004}$  with the Mn(A-site) ↔ Co(C-site) disorder near the Mn- $K$  absorption edge. (c) Comparison of  $I_{111}/I_{004}$  between the experiment and the calculation with the presence of the 40 %-Mn(B-site) ↔ Al(D-site) swapping, together with the 50 %-Mn(A-site) ↔ Co(C-site) swapping.

#### D. Atomic-level ordered structure

By using AXRD measurements and analyses [35, 53–55], we firstly focus on the microscopic structure of the 100°C-grown  $\text{Mn}_2\text{CoAl}$  films, where the AXRD measurement is performed at the standard undulator beamline BL13XU in SPring-8 using a six-circle diffractometer [56, 57]. To evaluate the atomic structures of the  $\text{Mn}_2\text{CoAl}$  film without ambiguity,

we need at least two intensity sets, i.e.,  $I_{002}/I_{004}$  and  $I_{111}/I_{004}$  [58]. Prior to the detailed measurements, we calculate X-ray energy dependence of integrated intensities of 004( $I_{004}$ ), 002( $I_{002}$ ), and 111( $I_{111}$ ) reflections from 6.3 to 6.7 keV around the Mn- $K$  absorption edge ( $\sim 6.54$  keV) of  $XA$ -type  $\text{Mn}_2\text{CoAl}$ . The solid curves in Figs. 5(a) and 5(b) show the X-ray energy dependence of the calculated intensities of  $I_{002}/I_{004}$  with Mn(B-site)-Co(C-site) disorder and  $I_{111}/I_{004}$  with Mn(A-site)-Co(C-site) disorder near the Mn- $K$  absorption edge of  $XA$ -type  $\text{Mn}_2\text{CoAl}$ . With increasing the Mn(A or B-site)-Co(C-site) disorder in  $XA$ -type  $\text{Mn}_2\text{CoAl}$ , the value of  $I_{002}/I_{004}$  near the Mn- $K$  absorption edge gradually decreases, leading to disappearance of a peak [Fig. 5(a)]. In addition, the shape of a peak for  $I_{111}/I_{004}$  near the Mn- $K$  absorption edge changes from convex upward to downward [Fig. 5(b)]. Considering these features, one can discuss the exact atomic-level ordered structure of the experimentally obtained  $\text{Mn}_2\text{CoAl}$  [35, 58].

In the same figures, we plot the experimentally obtained AXRD data for  $I_{002}/I_{004}$  and  $I_{111}/I_{004}$  near the Mn- $K$  absorption edge of the 100°C-grown  $\text{Mn}_2\text{CoAl}$  film with a thickness of 15 nm as red circles. By a comparison of  $I_{002}/I_{004}$  between the calculation and the experiment, we can recognize the absence of the Mn(B-site) $\leftrightarrow$ Co(C-site) disorder, tentatively indicating the presence of the  $XA$ -type structure in the 100°C-grown  $\text{Mn}_2\text{CoAl}$  film. In Fig. 5(b) the detailed comparisons of  $I_{111}/I_{004}$  between the calculation and the experiment can verify the presence of the Mn(A-site) $\leftrightarrow$ Co(C-site) disorder. Although the shape of the experimental data for  $I_{111}/I_{004}$  is similar to the calculation with the presence of the 50 %-Mn(A-site) $\leftrightarrow$ Co(C-site) disorder ( $L2_1B$ -type structure [36, 37]) in  $XA$ -type  $\text{Mn}_2\text{CoAl}$ , its intensity can not be reproduced precisely. Here we remind again the degrees of  $B2$  and  $L2_1$  ordering,  $S_{B2} \sim 1$  and  $S_{L2_1} \sim 0.4$ , respectively, in Fig. 1. Because the value of  $S_{L2_1}$  is relatively low, we should also take into account the presence of the Mn(B-site) $\leftrightarrow$ Al(D-site) disorder. Considering this fact, we show the calculated intensity of  $I_{111}/I_{004}$  with the presence of both the 50 %-Mn(A-site) $\leftrightarrow$ Co(C-site) disorder and the 40 %-Mn(B-site) $\leftrightarrow$ Al(D-site) disorder in Fig. 5(c). As a result, the shape and intensity of the experimental data for  $I_{111}/I_{004}$  are well reproduced. Given the structural characterizations in Figs. 1 and 5, we can determine the crystal structure of the 100°C-grown  $\text{Mn}_2\text{CoAl}$  films as a disordered  $L2_1B$ -type structure including the 50 %-Mn(A-site) $\leftrightarrow$ Co(C-site) swapping and the 40 %-Mn(B-site) $\leftrightarrow$ Al(D-site) swapping.

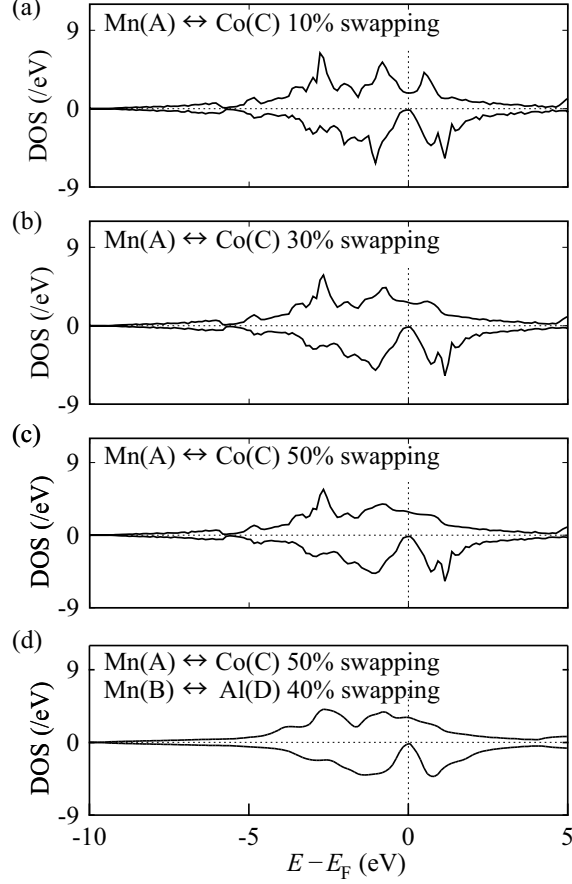


FIG. 6. Spin-resolved total density of states (DOS) of  $L2_1B$ -type  $Mn_2CoAl$  with the presence of (a) 10 %-, (b) 30 %-, and (c) 50 %-Mn(A-site) $\leftrightarrow$ Co(C-site) swapping. (d) Spin-resolved total DOS of disordered  $L2_1B$ -type  $Mn_2CoAl$  with the presence of both the 50 %-Mn(A-site) $\leftrightarrow$ Co(C-site) swapping and the 40 %-Mn(B-site) $\leftrightarrow$ Al(D-site) swapping.

### E. Electronic band structures

To discuss the electronic band structure in the disordered  $L2_1B$ -type  $Mn_2CoAl$  in detail, we perform first-principles density-functional theory calculations, where we use Akai-KKR [59]. The spin polarization with the semi-relativistic calculations is considered. A total of 195 independent  $k$ -points is sampled in the first Brillouin zone. The Moruzzi-Janak-Williams potential is used for the exchange-correlation calculations [60]. The disordered structures are treated in accordance with the coherent potential approximation (CPA) [61], in which the supercell method is not necessary because the multipole scattering effect is replaced by an effective-medium potential. Prior to the calculation for the disordered  $L2_1B$ -type

$\text{Mn}_2\text{CoAl}$  having some amount of  $\text{Mn}(\text{A-site}) \Leftrightarrow \text{Co}(\text{C-site})$  swapping and  $\text{Mn}(\text{B-site}) \Leftrightarrow \text{Al}(\text{D-site})$  swapping, we first confirmed the spin-resolved total density of states (DOS) for an  $XA$ -type structure, where the concentration of Co atoms at the A-site was assumed to 0%. As a result, although a small part of states was spilled into the gap due to CPA, the calculated total DOS reproduced an SGS-like electronic band structure (not shown here), as well as previous works [10, 27, 36].

Using this reliable method, we next calculate the DOSs for various concentrations of the swapping between  $\text{Mn}(\text{A-site})$  and  $\text{Co}(\text{C-site})$  to consider the experimental results in Fig. 5. Figures 6(a), 6(b), and 6(c) display the total DOS for  $L2_1B$ -type  $\text{Mn}_2\text{CoAl}$  with 10 %-, 30 %-, and 50 %- $\text{Mn}(\text{A-site}) \Leftrightarrow \text{Co}(\text{C-site})$  swapping, respectively. In these cases, the calculated magnetic moments are estimated to be  $2.01 \mu_{\text{B}}/\text{f.u.}$  for (a),  $2.01 \mu_{\text{B}}/\text{f.u.}$  for (b), and  $2.02 \mu_{\text{B}}/\text{f.u.}$  for (c), respectively. These results consistent with our experimental results shown in the inset of Fig. 3(a). In addition, the results for 50 %- $\text{Mn}(\text{A-site}) \Leftrightarrow \text{Co}(\text{C-site})$  swapping agree well with a previous work by Xin *et al.* [36], where the calculation methods in this work are different from those in Ref. [36]. Notably, although the gapless-like DOS structure of the majority spins gradually disappears with increasing the amount of  $\text{Mn}(\text{A-site}) \Leftrightarrow \text{Co}(\text{C-site})$  swapping and becomes toward the metallic-like structure, that of the minority spins remains even in the presence of the 50%- $\text{Mn}(\text{A-site}) \Leftrightarrow \text{Co}(\text{C-site})$  swapping. Namely, the  $\text{Mn}(\text{A-site}) \Leftrightarrow \text{Co}(\text{C-site})$  swapping in  $L2_1B$ -type  $\text{Mn}_2\text{CoAl}$  influences the electronic band structure only for the majority spins. Last, the influence of the  $\text{Mn}(\text{B-site}) \Leftrightarrow \text{Al}(\text{D-site})$  swapping on the electronic structure is considered in Fig. 6(d). As a result, the gapless-like DOS structure of the minority spins still remains even for the disordered  $L2_1B$ -type structure including the 40 %- $\text{Mn}(\text{B-site}) \Leftrightarrow \text{Al}(\text{D-site})$  swapping in addition to the 50 %- $\text{Mn}(\text{A-site}) \Leftrightarrow \text{Co}(\text{C-site})$  swapping. Even in this case, the magnetic moment is theoretically calculated to be  $2.01 \mu_{\text{B}}/\text{f.u.}$  From these theoretical calculations, it is found that the spin-gapless half-metals such as  $\text{Fe}_2\text{CoSi}$  [50] are realized for the  $100^\circ\text{C}$ -grown  $\text{Mn}_2\text{CoAl}$  films in this study.

#### IV. DISCUSSION

To overlook the recent results for  $\text{Mn}_2\text{CoAl}$ , we summarize the reported structural, electrical, and magnetic properties for bulk [10, 35] and thin-films [28–34]  $\text{Mn}_2\text{CoAl}$  in Table

TABLE I. Comparison of structural characterization, electrical and magnetic properties of bulk and thin-film  $\text{Mn}_2\text{CoAl}$ .

Sample	Method	Structure	Magnetic moment ( $\mu_B/\text{f.u.}$ )	Temperature dependence of $\rho$	$n$ or $p$ ( $\text{cm}^{-3}$ )	$\sigma_{\text{AHC}}$ (S/cm)	MR sign
Bulk [10]	Arc melting (Unknown)	Unknown	2.0 (< 5 K)	Negative	$1.7 \times 10^{20}$ (2 K) $n$ -type [63]	22 (2 K)	Positive ( $\leq 100$ K)
Bulk [35]	Arc melting (1100°C)	Multiphase w/ disordered $XA$	2.6 (5 K)	Negative	$\sim 2.9 \times 10^{22}$ (10 K) $p$ -type	25 (10 K)	N/A
[001]-oriented film [29]	Sputtering (400°C)	$B2$	$\sim 1.9$ (5K)	Negative	$1.6 \times 10^{20}$ (5 K) $p$ -type	$\sim 5.0$ (5 K)	Negative
Epitaxial film [30]	Sputtering (500°C)	$B2$	1.0 (RT)	Negative	$2.0 \times 10^{21}$ $p$ -type	78 (5 K)	Negative
Epitaxial film [31]	Sputtering (400°C)	$B2$	$\sim 1.8$ (RT)	Negative	$6.0 \times 10^{20}$ (4 K) $p$ -type	$\sim 25$ (4 K)	Negative
Epitaxial film [34]	Sputtering (550°C)	$B2$	$\sim 1.0$ (10 K)	Negative	$2.0 \times 10^{22}$ $p$ -type	N/A	Negative
Epitaxial film [28]	MBE (325°C)	Disordered $L2_1$ ( $S_{B2} \sim 0.43$ )	1.0 (10 K)	Positive ( $\leq 200\text{K}$ ) Negative ( $> 200$ K)	$4.0 \times 10^{22}$ (RT) $n$ -type	12 (RT)	Negative
Epitaxial film [32]	MBE (300°C)	Disordered $L2_1$ [58]	$\sim 1.9$ (10 K)	Negative	$\sim 1.2 \times 10^{22}$ (10 K) $p$ -type	$\sim 8.9$ (10 K)	Negative
Epitaxial film [33]	MBE (150°C)	$B2$ ( $S_{B2} \sim 0.89$ )	N/A	Negative	N/A	N/A	Negative
Epitaxial film (this study)	MBE (100°C)	Single phase Disordered $L2_1B$	$\sim 2.0$ (10 K)	Negative	$\sim 2.0 \times 10^{22}$ (10 K) $p$ -type	$\sim 16$ (10 K)	Positive (10 K)

I. From these comparisons, although all of the reports have so far shown the reasonable magnetic moment, the weak negative temperature-dependent  $\rho$ , and low  $\sigma_{\text{AHC}}$ , there has been almost no correlation between them and the formation of the  $XA$ -type structure. In addition to the above situation, only two of studies including this work have shown the PLMR effect, which may be due to the quantum linear MR effect related to the gapless-like special electronic structure near the Fermi level [18, 48].

Since homogeneous and single-phase  $\text{Mn}_2\text{CoAl}$  epitaxial films have been demonstrated in this study, the correlation between the presence of the PLMR effect and the atomic-level ordered structure can be considered. Taking into account the previous works [10, 50] and the results in Fig. 6, we can firstly discuss that the PLMR effect observed in the disordered  $L2_1B$ -type  $\text{Mn}_2\text{CoAl}$  epitaxial films originates from the quantum linear MR effect due to the gapless electronic band structure related to the minority states near the Fermi level.



Recently, although the PLMR effect due to the quantum linear MR effect was also observed for the partially disordered CoFeVSi Heusler alloy [23, 25], the magnitude of the PLMR was quite small because of the presence of large carrier concentrations due to the Co-Fe disorder. For the disordered  $L2_1B$ -type  $Mn_2CoAl$  epitaxial films, the magnitude of the PLMR in Fig. 4 is also small compared to that for the bulk  $Mn_2CoAl$  [10]. We infer that the small PLMR effect is affected by the presence of the low carrier mobility ( $\sim 0.6 \text{ cm}^2/\text{V}\cdot\text{s}$ ) arising from impurity and/or spin-dependent scattering in the large DOS of the majority spins. Next, we can consider the realization of a conventional half-metallic property with a very small energy gap [62]. If the half-metallic electronic band structure with a small energy gap less than several meV was realized in disordered  $L2_1B$ -type  $Mn_2CoAl$  epitaxial films, the spin-magnon scattering could be expected to freeze out only at low temperatures less than 10 K. The similar features have already been observed in a famous half-metal,  $L2_1$ -type  $Co_2FeSi$ , with a small energy gap [62]. Thus, there are several possibilities of the mechanism of the manifestation for the PLMR effect even in disordered  $L2_1B$ -type  $Mn_2CoAl$  epitaxial films.

On the basis of these considerations, we conclude that the observation of the PLMR effect is not evidence for the formation of  $XA$ -type  $Mn_2CoAl$ . We suggest that it is effective to perform disorder-sensitive structural analyses such as AXRD [35, 53–55, 58] and extended X-ray absorption fine structure (EXAFS) [64–67] for obtaining the evidence for the formation of the  $XA$ -type structure. Furthermore, the values of the carrier concentration shown in Table I are largely scattered from sample to sample, which are not consistent with the quality of  $Mn_2CoAl$  samples. The carrier concentration for all the samples should be estimated accurately from Hall-effect measurements of fabricated Hall-bar devices.

## V. CONCLUSION

It has been believed that the PLMR effect at low temperatures in  $Mn_2CoAl$  originates from the quantum linear MR effect in the gapless electronic band structures near the Fermi level, which is likely to be evidence for the realization of the  $XA$ -type structure [10]. Although lots of  $Mn_2CoAl$  films have so far been reported, the detailed discussion on the correlation between the PLMR effect and the presence of the  $XA$ -type structure has not been shown yet. In this article, we observed the PLMR effect at 10 K in homogeneous and single-phase  $Mn_2CoAl$  epitaxial films grown by MBE at  $100^\circ\text{C}$  in addition to the reasonable

magnetic moment, the weak negative temperature-dependent  $\rho$ , and low  $\sigma_{\text{AHC}}$ . However, from AXRD measurements and its analyses, we found that the 100°C-grown  $\text{Mn}_2\text{CoAl}$  epitaxial film is not an  $XA$ -type structure but is a disordered  $L2_1B$ -type structure having some amount of the  $\text{Mn}(\text{A-site}) \Leftrightarrow \text{Co}(\text{C-site})$  swapping and the  $\text{Mn}(\text{B-site}) \Leftrightarrow \text{Al}(\text{D-site})$  swapping. On the basis of first-principles density-functional theory calculations, we conclude that the PLMR effect observed in the disordered  $L2_1B$ -type  $\text{Mn}_2\text{CoAl}$  epitaxial films originates from the quantum linear MR effect due to the gapless electronic band structure related to the minority states near the Fermi level or from the freeze-out of the spin-magnon scattering due to the half-metallic electronic band structure with a small energy gap less than several meV. Namely, there is still no direct evidence for the SGS-like band structure related to the PLMR effect at low temperatures because the PLMR effect can also occur from spin-gapless half-metals such as  $\text{Fe}_2\text{CoSi}$  [50] and  $\text{CoFeVSi}$  [23, 25] or conventional half-metals with a small energy gap such as  $\text{Co}_2\text{FeSi}$  [62]. To obtain definite evidence for the formation of the  $XA$ -type structure, element-specific and disorder-sensitive structural analyses such as AXRD and EXAFS, even for bulk  $\text{Mn}_2\text{CoAl}$ , are effective.

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